

### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

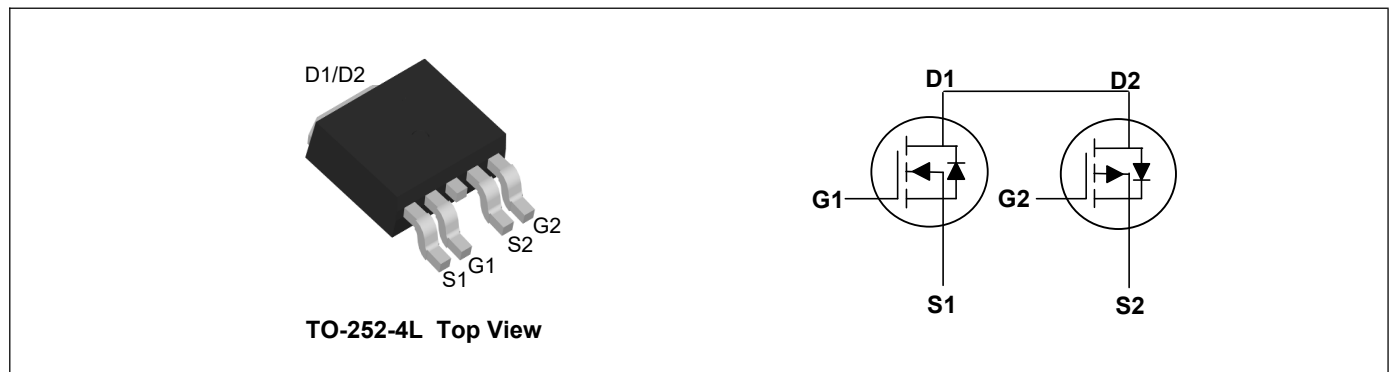
### Applications

- High Frequency Point-of-Load, Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch

### Product Summary



	N-Ch	P-Ch	
$V_{DS}$	60	-60	V
$I_D$	20	-12	A
$R_{DS(ON)}$ (at $V_{GS}=\pm 10V$ )	40	100	m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}=\pm 4.5V$ )	50	125	m $\Omega$



### Absolute Maximum Ratings ( $T_c=25^\circ\text{C}$ , unless otherwise noted)

Parameter	Symbol	N-Ch	P-Ch	Units
Drain-Source Voltage	$V_{DS}$	60	-60	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	$\pm 20$	V
Continuous Drain Current, $V_{GS} @ \pm 10V^1$	$I_D @ T_c=25^\circ\text{C}$	20	-12	A
Continuous Drain Current, $V_{GS} @ \pm 10V^1$	$I_D @ T_c=100^\circ\text{C}$	14	-8.5	A
Pulsed Drain Current <sup>2</sup>	$I_{DM}$	60	-30	A
Single Pulse Avalanche Energy <sup>3</sup>	EAS	22	29.8	mJ
Avalanche Current	$I_{AS}$	21	-24.4	A
Total Power Dissipation <sup>4</sup>	$P_D @ T_c=25^\circ\text{C}$	50	50	W
Storage Temperature Range	$T_{STG}$	-55 to 175		$^\circ\text{C}$
Operating Junction Temperature Range	$T_J$	-55 to 175		$^\circ\text{C}$

### Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Ambient <sup>1</sup>	$R_{\theta JA}$	---	62	$^\circ\text{C/W}$
Thermal Resistance Junction-Case <sup>1</sup>	$R_{\theta JC}$	---	3	$^\circ\text{C/W}$

**N-Ch Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	60	---	---	V
Static Drain-Source On-Resistance <sup>2</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A	---	---	40	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =7A	---	---	50	mΩ
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.0	---	2.5	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	---	---	1	uA
		V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C	---	---	5	uA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	---	---	±100	nA
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =15A	---	25.3	---	S
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =48V, V <sub>GS</sub> =10V, I <sub>D</sub> =15A	---	19	---	nC
Gate-Source Charge	Q <sub>gs</sub>		---	2.5	---	
Gate-Drain Charge	Q <sub>gd</sub>		---	5	---	
Turn-On Delay Time	T <sub>d(on)</sub>	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V, R <sub>G</sub> =3.3Ω, I <sub>D</sub> =15A	---	2.8	---	ns
Rise Time	T <sub>r</sub>		---	16.6	---	
Turn-Off Delay Time	T <sub>d(off)</sub>		---	21.2	---	
Fall Time	T <sub>f</sub>		---	5.6	---	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz	---	1027	---	pF
Output Capacitance	C <sub>oss</sub>		---	65	---	
Reverse Transfer Capacitance	C <sub>rss</sub>		---	46	---	

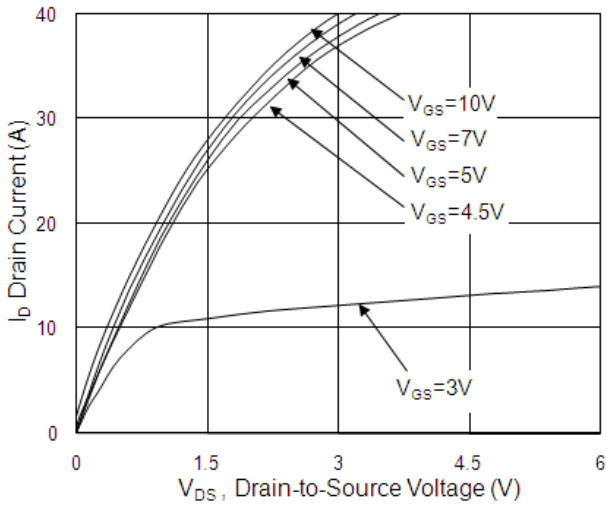
**Drain-Source Diode Characteristics**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current <sup>1,5</sup>	I <sub>S</sub>	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	---	---	10	A
Diode Forward Voltage <sup>2</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C	---	---	1.2	V

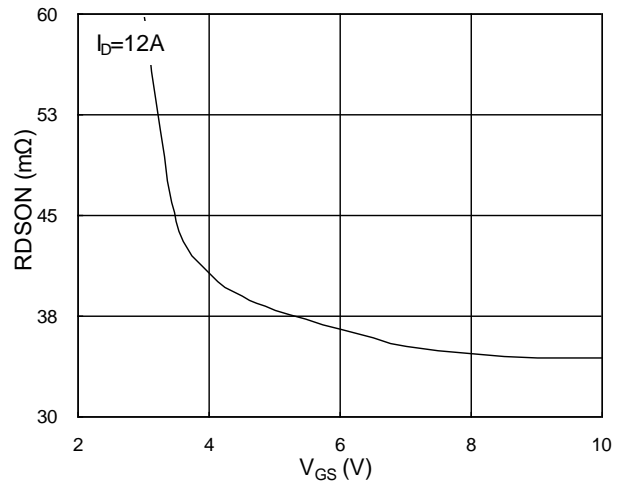
**Note:**

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
3. The EAS data shows Max. rating. The test condition is V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

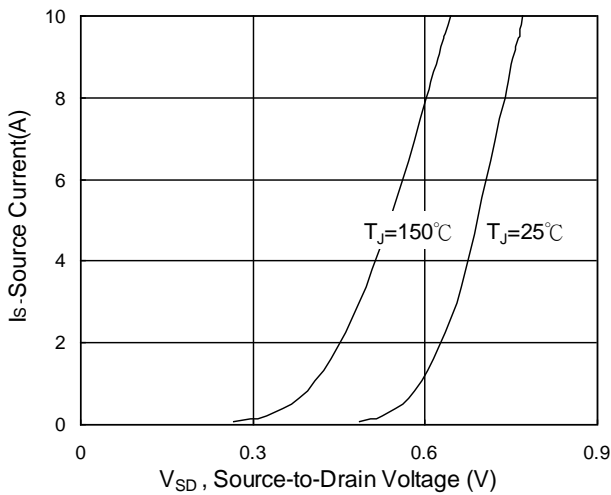
**N-Ch Typical Characteristics**



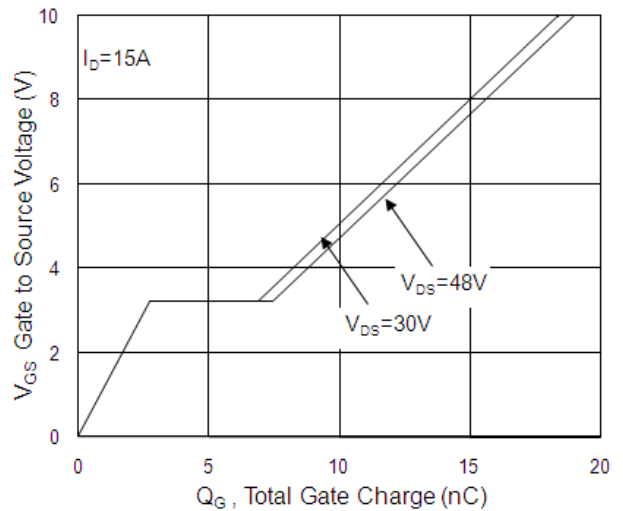
**Fig.1 Typical Output Characteristics**



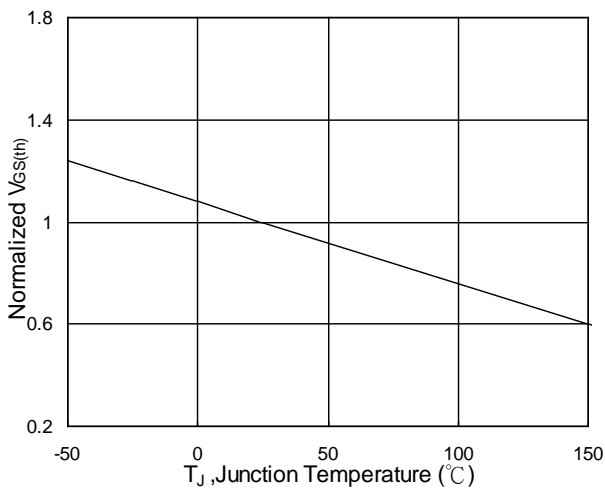
**Fig.2 On-Resistance vs. G-S Voltage**



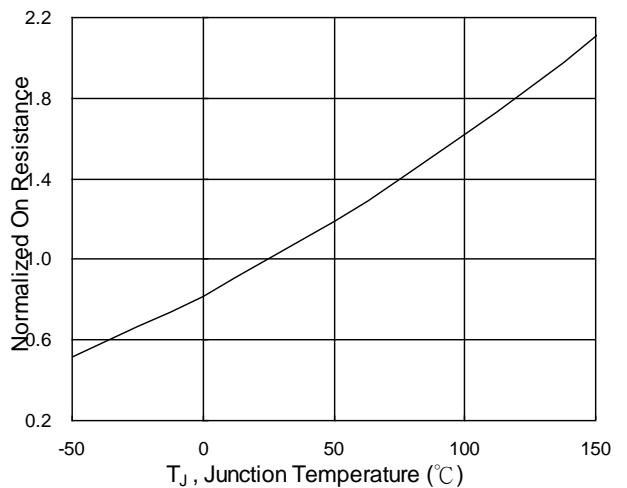
**Fig.3 Source Drain Forward Characteristics**



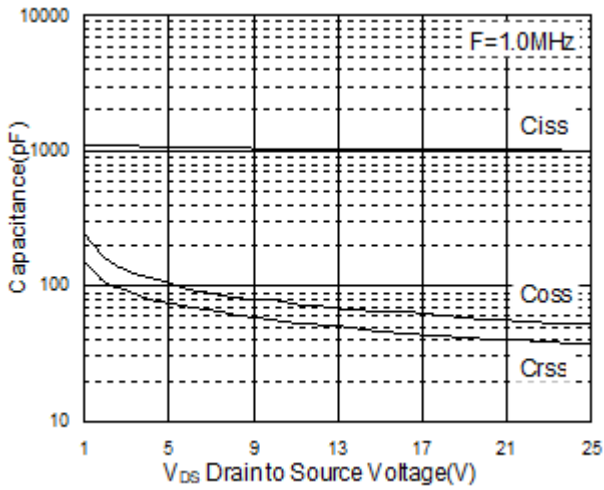
**Fig.4 Gate-Charge Characteristics**



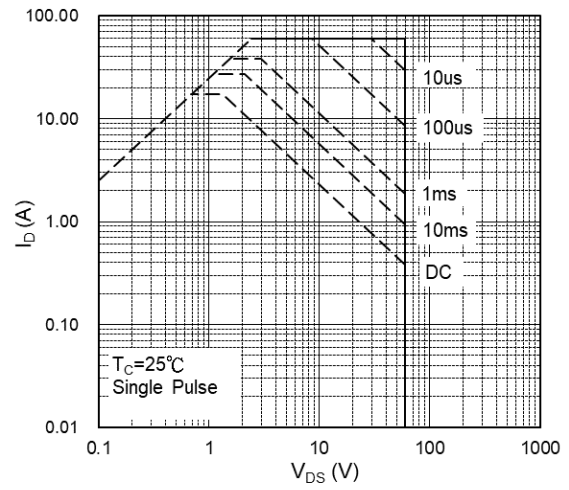
**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



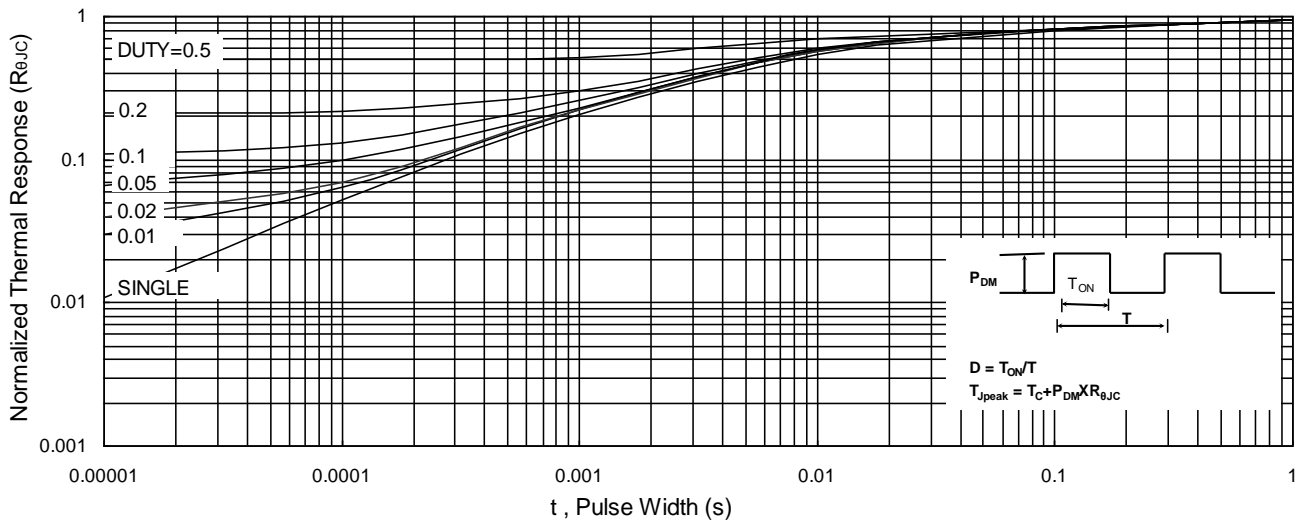
**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**



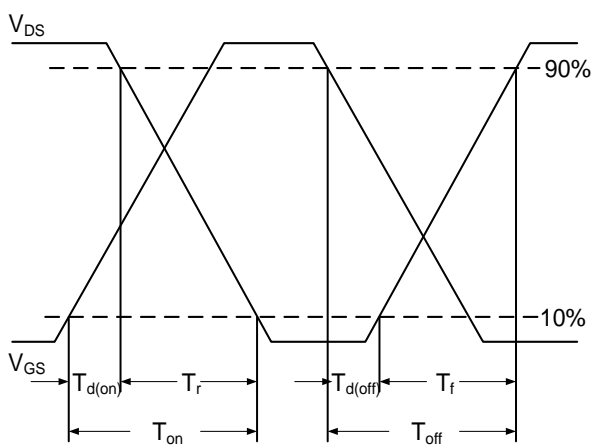
**Fig.7 Capacitance**



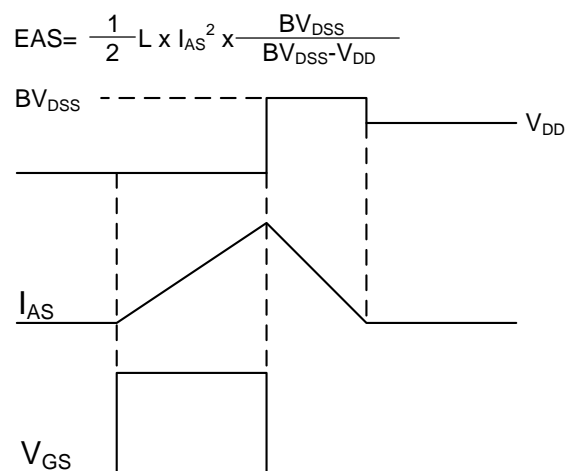
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

**P-Ch Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise noted)**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-60	---	---	V
Static Drain-Source On-Resistance <sup>2</sup>	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-10A$	---	---	100	$m\Omega$
		$V_{GS}=-4.5V, I_D=-5A$	---	---	125	$m\Omega$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=-250\mu A$	-1.0	---	-2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=-48V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	---	---	1	$\mu A$
		$V_{DS}=-48V, V_{GS}=0V, T_J=55^{\circ}\text{C}$	---	---	5	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	$\pm 100$	nA
Forward Transconductance	$g_{fs}$	$V_{DS}=-5V, I_D=-4A$	---	8.7	---	S
Total Gate Charge	$Q_g$	$V_{DS}=-12V, V_{GS}=-4.5V, I_D=-6A$	---	11.8	---	nC
Gate-Source Charge	$Q_{gs}$		---	1.9	---	
Gate-Drain Charge	$Q_{gd}$		---	6.5	---	
Turn-On Delay Time	$T_{d(on)}$	$V_{DD}=-15V, V_{GS}=-10V, R_G=3.3\Omega, I_D=-1A$	---	8.8	---	ns
Rise Time	$T_r$		---	19.6	---	
Turn-Off Delay Time	$T_{d(off)}$		---	47.2	---	
Fall Time	$T_f$		---	9.6	---	
Input Capacitance	$C_{iss}$	$V_{DS}=-15V, V_{GS}=0V, f=1\text{MHz}$	---	1080	---	pF
Output Capacitance	$C_{oss}$		---	73	---	
Reverse Transfer Capacitance	$C_{rss}$		---	50	---	

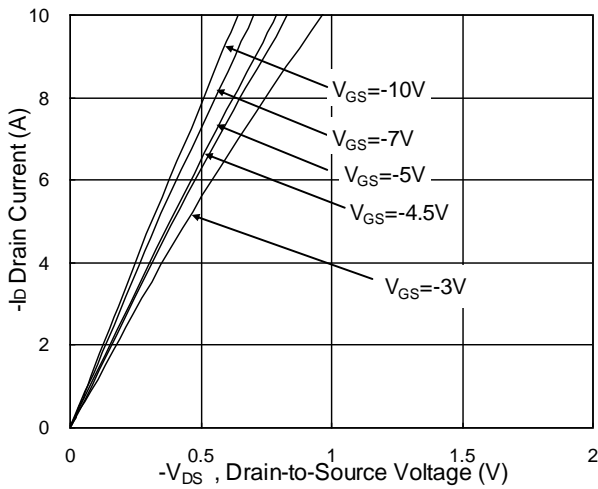
**Drain-Source Diode Characteristics**

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Continuous Source Current <sup>1,5</sup>	$I_S$	$V_G=V_D=0V$ , Force Current	---	---	-10	A
Diode Forward Voltage <sup>2</sup>	$V_{SD}$	$V_{GS}=0V, I_S=-1A, T_J=25^{\circ}\text{C}$	---	---	-1	V

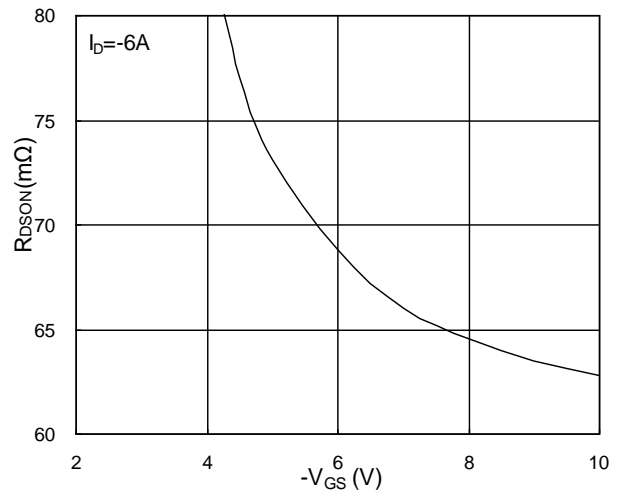
**Note:**

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
2. The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
3. The EAS data shows Max. rating. The test condition is  $V_{DD}=-25V, V_{GS}=-10V, L=0.1\text{mH}$
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

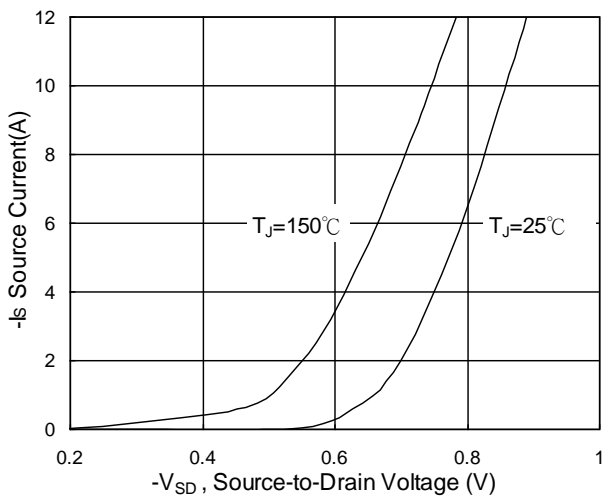
**P-Ch Typical Characteristics**



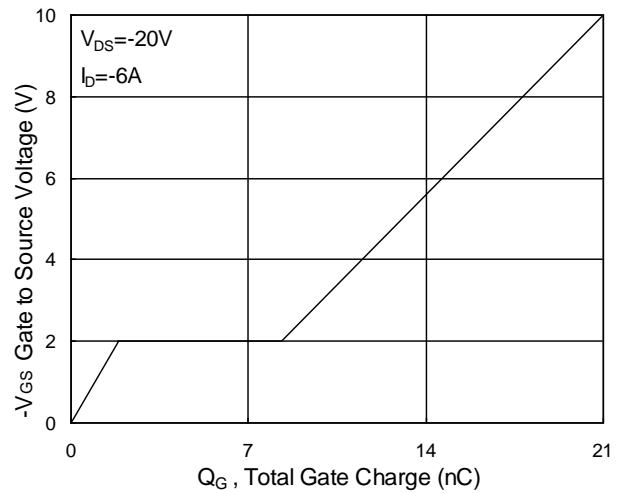
**Fig.1 Typical Output Characteristics**



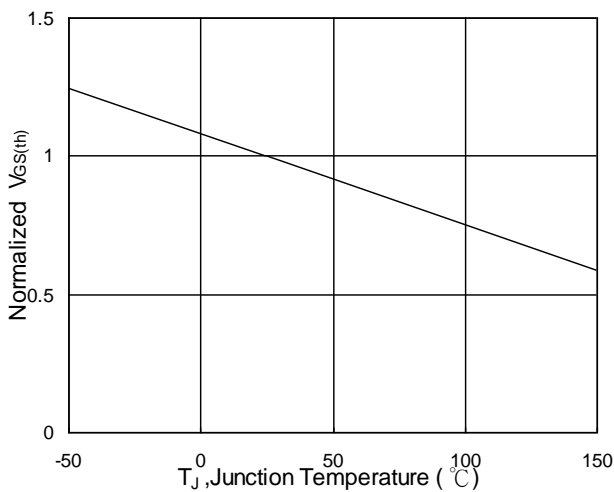
**Fig.2 On-Resistance vs. G-S Voltage**



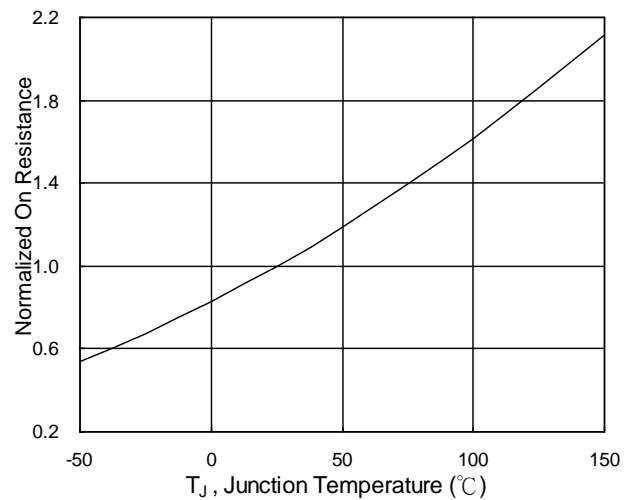
**Fig.3 Source Drain Forward Characteristics**



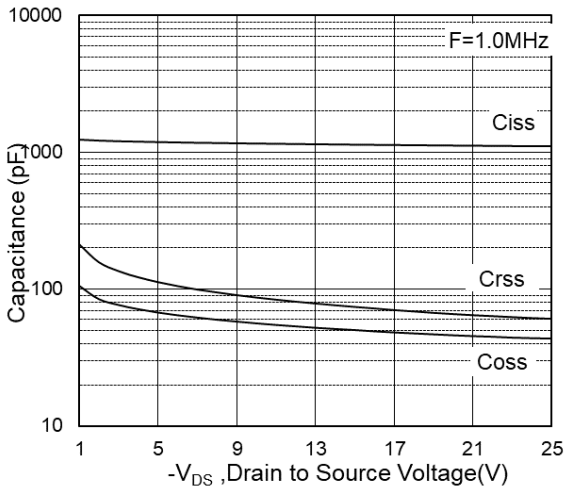
**Fig.4 Gate-Charge Characteristics**



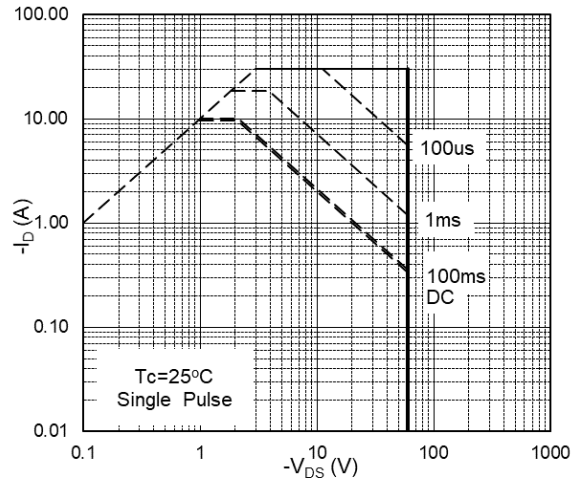
**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**



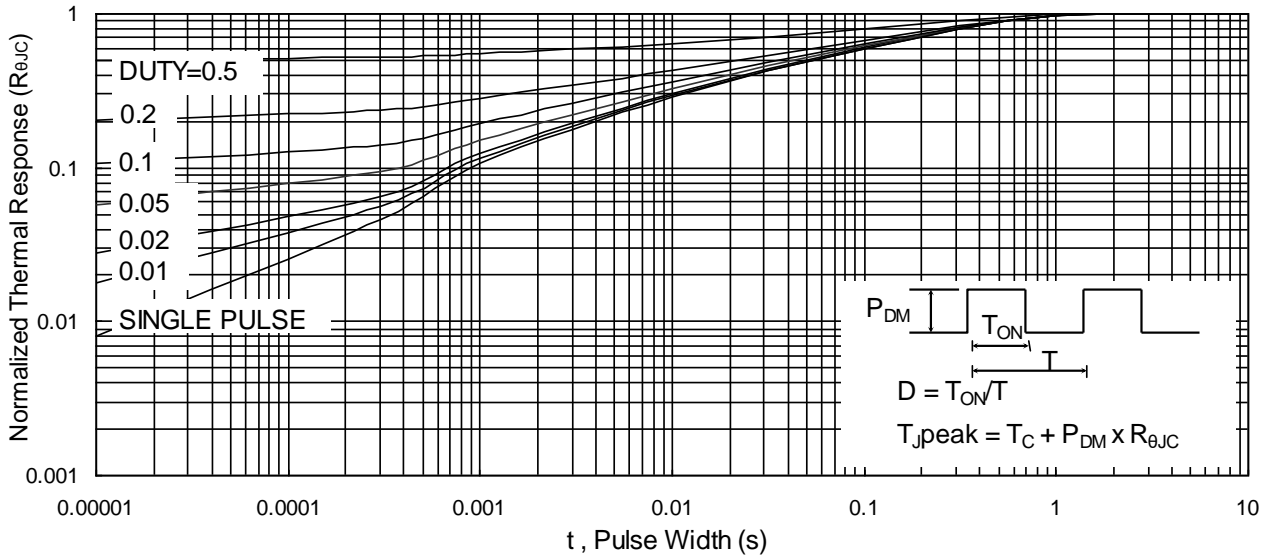
**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**



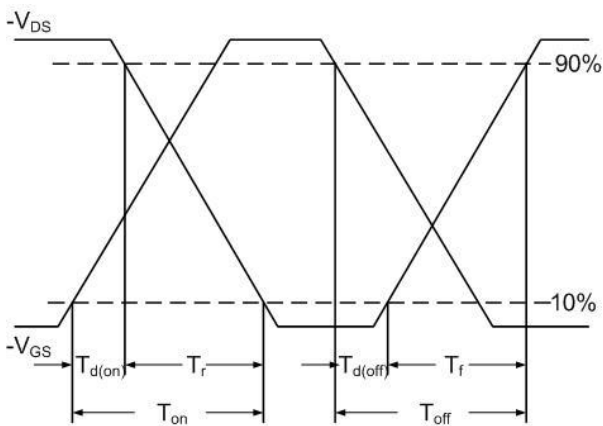
**Fig.7 Capacitance**



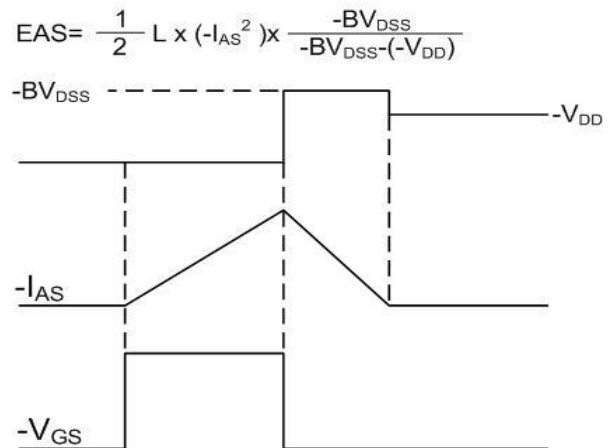
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**

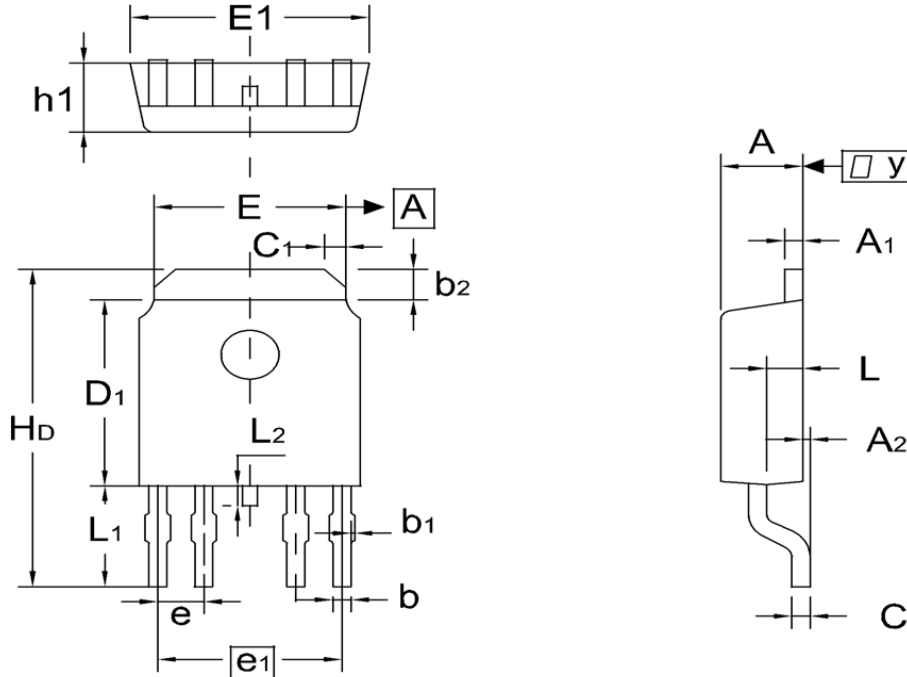


**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

**TO-252-4L Package Outline Dimensions**



**DIMENSIONS** ( unit : mm )

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
A	2.1	2.3	2.5	A <sub>1</sub>	0.4	0.5	0.6
A <sub>2</sub>	--	--	0.3	b	0.4	0.5	0.6
b <sub>1</sub>	--	--	0.1	b <sub>2</sub>	0.8	1.0	1.2
C	0.4	0.5	0.6	C <sub>1</sub>	0.4	0.6	0.8
D <sub>1</sub>	5.7	6.1	6.5	E	5.0	5.3	5.6
E <sub>1</sub>	6.3	6.6	6.9	e	--	1.27	--
e <sub>1</sub>	--	5.08	--	H <sub>D</sub>	9.6	10.0	10.4
h <sub>1</sub>	2.1	2.3	2.5	L	0.80	1.0	1.2
L <sub>1</sub>	2.6	2.9	3.2	L <sub>2</sub>	0.35	0.65	0.95